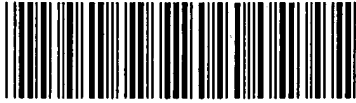


Search Notes

Application/Control No.

10/775,521

Examiner

Chun-Kuan (Mike) Lee

Applicant(s)/Patent under
Reexamination

NEMAZIE, SAM

Art Unit

2181

SEARCHED

Class	Subclass	Date	Examiner
710	74	11/26/2007	CKL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated EAST search:US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT Updated Inventor search utilizing eDan and EAST	11/26/2007	CKL